



IPW

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Serial No.: 10/726,891

Confirmation No.: 4184

In re Application of:

Satoru KAMANO et al.

Group Art Unit: 2829

Filed: December 4, 2003

Examiner: Tung X. Nguyen

For: ANCILLARY EQUIPMENT FOR TESTING
SEMICONDUCTOR INTEGRATED CIRCUIT

AMENDMENT

MAIL STOP AMENDMENT
Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450

Sir:

In response to the Office Action mailed November 18, 2005
please amend the above-identified application as follows: